

#### **P-Channel MOSFET**

### **General Description**

The WSD30L68DN33 is the highest performance trench P-Channel MOSFETs with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSD30L68DN33 meet the RoHS and Green Product requirement 100%  $E_{AS}$  guaranteed with full function reliability approved.

#### Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline

**Absolute Maximum Ratings** 

- 100% E<sub>AS</sub> Guaranteed
- Green Device Available

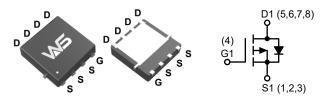
#### **Product Summery**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	Ι <sub>D</sub>
-30V	5.8mΩ	-68A

#### Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

#### **DFN3X3-8L Pin Configuration**



Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	-30	v
V <sub>GS</sub>	Gate-Source Voltage	±20	
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-68	
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup> -30	
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	-180	
E <sub>AS</sub>	Single Pulse Avalanche Energy $^3$	125	mJ
I <sub>AS</sub>	Avalanche Current	-40	A
P <sub>D</sub> @T <sub>C</sub> =25°C	Power Dissipation <sup>4</sup>	69	w
P <sub>D</sub> @T <sub>A</sub> =25°C	Power Dissipation <sup>4</sup>	2.5	
T <sub>STG</sub>	Storage Temperature Range -55 to 150		°C
TJ	Operating Junction Temperature Range	-55 to 150	

#### **Thermal Data**

Symbol	Parameter	Тур.	Max.	Units
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient <sup>1</sup>		60	
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient $^1$ (t ≤10s)		20	°C/W
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case <sup>1</sup>		3.5	



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#### **Electrical Characteristics** (T<sub>J</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage V <sub>GS</sub> =0V , I <sub>D</sub> =-250µA		-30			V
$\Delta BV_{DSS}/\Delta T_{J}$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C, I <sub>D</sub> =-1mA		-0.0232		V/°C
B	Statia Drain Sauras On Desistance 2	V <sub>GS</sub> =-10V , I <sub>D</sub> =-20A		5.8	7.8	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-10A		10	18	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage		-1.3	-1.8	-2.5	V
$\Delta V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	- V <sub>GS</sub> =V <sub>DS</sub> , Ι <sub>D</sub> =-250μΑ		4.6		mV/°C
	Drain Source Lookage Current	$V_{DS}$ =-24V , $V_{GS}$ =0V , $T_J$ =25°C			-1.0	
I <sub>DSS</sub>	Drain-Source Leakage Current	$V_{DS}$ =-24V , $V_{GS}$ =0V , $T_{J}$ =55°C			-5.0	μA
I <sub>GSS</sub>	Gate-Source Leakage Current V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V				±100	nA
9 <sub>fs</sub>	Forward Transconductance V <sub>DS</sub> =-5V , I <sub>D</sub> =-10A			10		S
R <sub>g</sub>	Gate Resistance	$V_{DS}$ =0V , $V_{GS}$ =0V , f = 1.0MHz		1.2		Ω
Qg	Total Gate Charge (-4.5V)			60		
Q <sub>gs</sub>	Gate-Source Charge	TV <sub>DS</sub> =-15V,V <sub>GS</sub> =-10V, I <sub>D</sub> =-18A		9		nC
Q <sub>gd</sub>	Gate-Drain Charge			15		
T <sub>d(on)</sub>	Turn-On Delay Time			16		
T <sub>r</sub>	Rise Time $V_{DD}$ =-15V , $V_{GS}$ =-10V ,Turn-Off Delay Time $R_G$ =3.3 $\Omega$ , $I_D$ =-1A			38		
T <sub>d(off)</sub>				50		ns
T <sub>f</sub>	Fall Time	]		12		
C <sub>iss</sub>	Input Capacitance			3415		
C <sub>oss</sub>	Output Capacitance $V_{DS}$ =-20V , $V_{GS}$ =0V , f = 1.0MHz			245		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	]		131		

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>5</sup>	V <sub>DD</sub> =-25V, L=0.5mH, I <sub>AS</sub> =-40A	78			mJ

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
۱ <sub>S</sub>	Continuous Source Current <sup>1,6</sup>				-70	Α
I <sub>SM</sub>	Pulsed Source Current <sup>2,6</sup>	V <sub>G</sub> =V <sub>D</sub> =0V,Force Current			-180	A
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V,I <sub>S</sub> =-1A,T <sub>J</sub> =25°C			-1.2	V
t <sub>rr</sub>	Reverse Recovery Time			22		ns
Q <sub>rr</sub>	Reverse Recovery Charge	l <sub>F</sub> =-20A, dl/dt=100A/µs,T <sub>J</sub> =25°C		75		nC

Note:

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper,t≤10sec.

2. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%

3. The E\_{AS} data shows Max. rating . The test condition is  $V_{DD}$ =-25V,  $V_{GS}$ =-10V, L=0.5mH, I<sub>AS</sub>=-40A

4. The power dissipation is limited by 150  $^{\circ}\text{C}$  junction temperature.

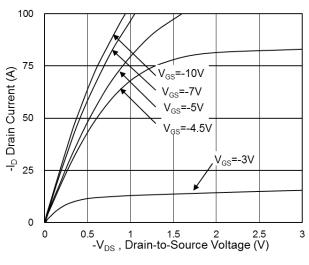
5. The Min. value is 100%  $\, E_{\text{AS}} \,$  tested guarantee.

6. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



#### P-Channel MOSFET

### **Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

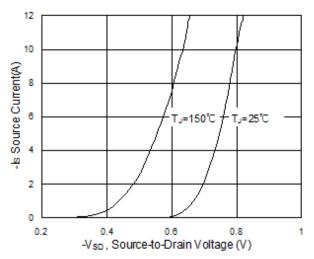
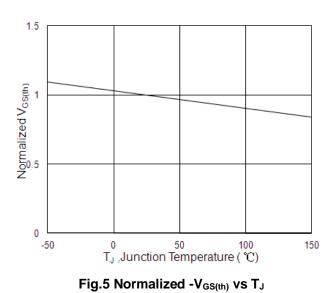


Fig.3 Source Drain Forward Characteristics



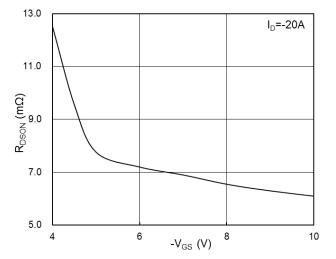


Fig.2 On-Resistance vs G-S Voltage

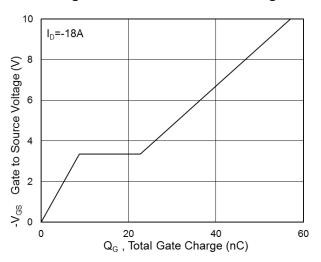
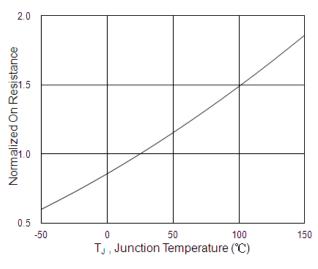
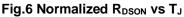


Fig.4 Gate-Charge Characteristics

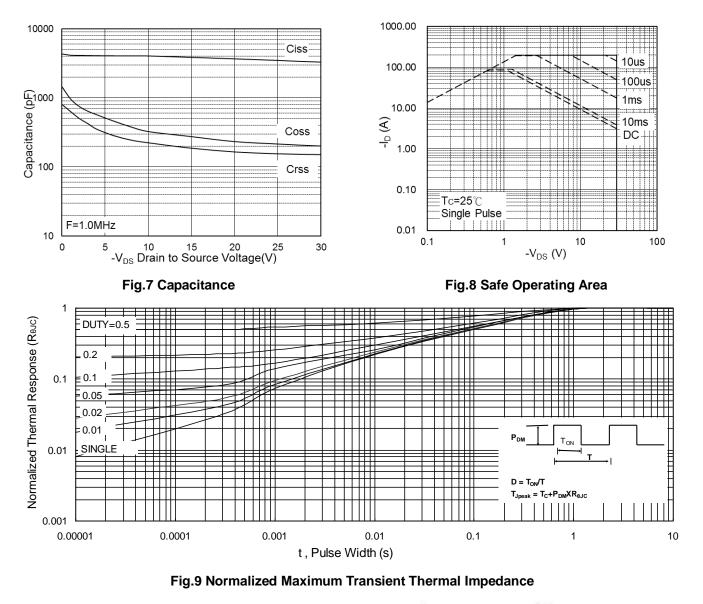






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## **Typical Characteristics (Cont.)**



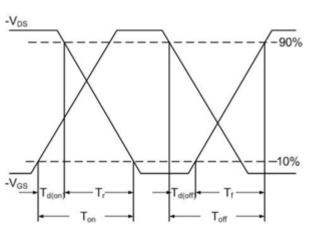


Fig.10 Switching Time Waveform

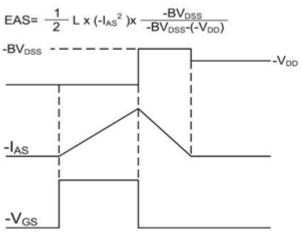
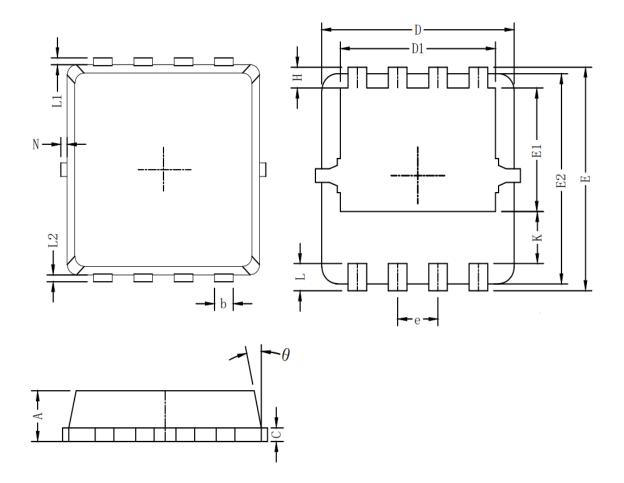


Fig.11 Unclamped Inductive Switching Waveform



P-Channel MOSFET

### Packaging information



Symbol	Dim in mm				
	min	typ	max		
А	0.6	0.75	0.9		
b	0.2	0.3	0.4		
С	0.15	0.2	0.25		
D	3	3.1	3.2		
D1	2.3	2.45	2.6		
E	3.15	3.3	3.45		
E1	1.43	1.73	1.93		
E2	2.9	3.05	3.2		
е	0.65BSC				
Н	0.2	0.35	0.5		
К	0.57	0.77	0.87		
L	0.3	0.4	0.5		
L1/L2	0.1REF				
θ	8°	10°	13°		
Ν	0		0.15		



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